

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/790,804	TAKAMURA, TAKASHI	
		Examiner	Art Unit	Page 1 of 1
		A. Sefer	2826	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0101532	08-2002	Takayama et al.	348/362
*	B	US-2002/0036300	03-2002	Pain et al.	257/184
	C	US-			
	D	US-			
	E	US-			
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	M	US-			

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